

<b>Notice of References Cited</b>		Application/Control No. 10/565,302	Applicant(s)/Patent Under Reexamination SUDOH ET AL.	
		Examiner AMANDA BARROW	Art Unit 1795	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,194,099 b1	02-2001	Gernov et al.	429/213
*	B	US-6,361,900 b1	03-2002	Parmentier et al.	429/231.8
*	C	US-6,444,347 b1	09-2002	Ouvry et al.	429/44
*	D	US-2003/0049531 a1	03-2003	Qu, Deyang	429/224
*	E	US-2003/0118908	06-2003	Ishikawa et al.	429/231.8
*	F	US-6,040,092	03-2000	Yamada et al.	429/331
*	G	US-2003/0124424 a1	07-2003	Takahashi et al.	429/231.1
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 1,191,131	03-2002	European Patent	Nishimura et al.	D01F 9/127
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.